

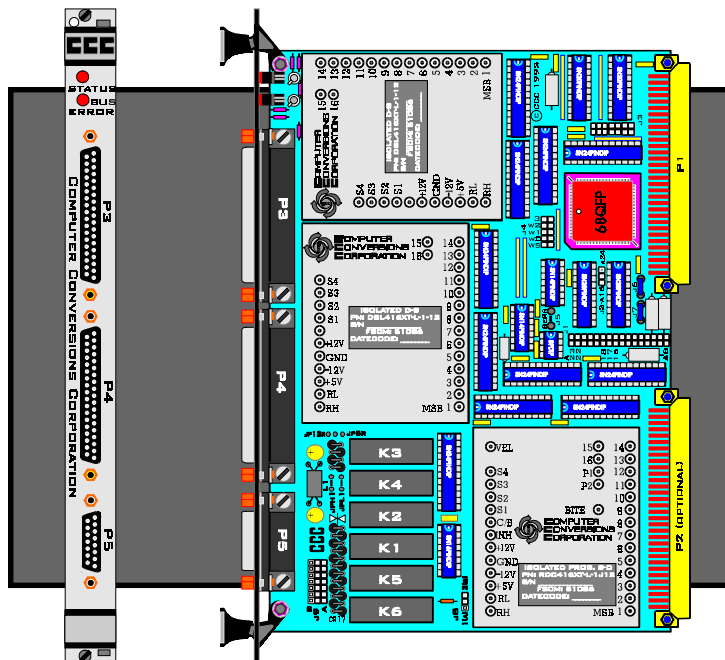
COMPUTER CONVERSIONS CORPORATION

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VBT & VBDT SERIES VME BUS W/BUILT-IN TEST BUS SYNCHRO/RESOLVER CONVERTERS

FEATURES

- True Wrap-Around Converter Testing
- On and Off Card Loop-Back Testing
- Expandable Off-Card Test Bus'
- Isolation Through-Out Implementation
- Real-Time and Off-Line Testing
- I/O Can Be Disconnected/Module
- Verification of On Verses Off Card Faults
- Intelligent Test Bus Routing Logic
- Dual Off-Card Buses Per Card
- Elaborate Backplanes Not Required
- Upto 6 Isolated Channels/Card



Overview

The VBT and VBDT Cards are full function 3 and 6 channel VME Bus cards with added support logic for CCC's "Advanced Random Signal Test Bus™" (ARS T-Bus™).

The "ARS T-Bus™" uses a *interlocked relay switching matrix*, that allows all the signal lines *from one converter* module to be selectively routed *to any other compatible converter* modules, that reside *on the same card, or any other VBT or VBDT Card tied into the system*.

Compatible modules on any board are allowed to be tied between, or to, each other for loopback, Wrap-around testing and real time systems test.

The ARS T-Bus™ facilities *Real-Time on-line (live) and off-line testing*, and program controlled automatic testing *down to the component converter level*.

Because the ARS T-Bus™ allows the program to run "live" (real-time testing) or, selectively disconnect the actual field wired signal lines in route to each converter;

Automatic System Debug, can easily discern converter verses field wiring or sensor faults in the overall system, and evaluate the differences between loaded and unloaded converter performance.

Multiple Inter-Board Test Paths

The on-board *ARS T-Bus™* may be unstrapped for routing to any one of *two different and distinct inter-card test buses* that are daisy chained between boards via the *P2 expansion port or the Front Panel (T-Bus™)* connector ports.

The use of two-*different inter-card test buses* allows the user to run *separate high voltage synchro, and low voltage synchro buses within the same system*. Furthermore, the two different *Inter-card buses can be staggered for expansion into a third RVDT/LVDT test bus, or even a fourth or fifth multichannel A-D/D-A test bus* etc.

Test Bus Integrity

Unlike other test methods that employ stepping up/down signal voltages for testing, or fixed step changes to verify limited functionality; the "*ARS T-Bus™*" *routes the real (true voltage) signal lines as they enter the circuit card, this permits 100% true testing ability*.

The use of real (true-voltage) signal lines, and a *true isolated test bus* for Loop-Back allows the program to *discern positively, (with confidence) whether a failure is an on-board or field fault*.

(Request full VBT/VBDT Data Sheets, Block Diagrams on following page)

Safe-Lock™ control logic

The *ARS T-Bus™* uses a unique register based control structure employing the use of CCC's "*Safe-Lock™ control logic*". A single *Safe-Lock™ Command Register is provided to request the desired routing of signals*, and a *Safe-Lock™ Status Register is provided to confirm if and when the commanded routing is set*.

All the *ARS T-Bus™*; interlock, non-contention, bus-busy, time-out and signal compatibility checking logic, is transparent to the user, and *automatically controlled with the on-board Safe-Lock™ control logic*.

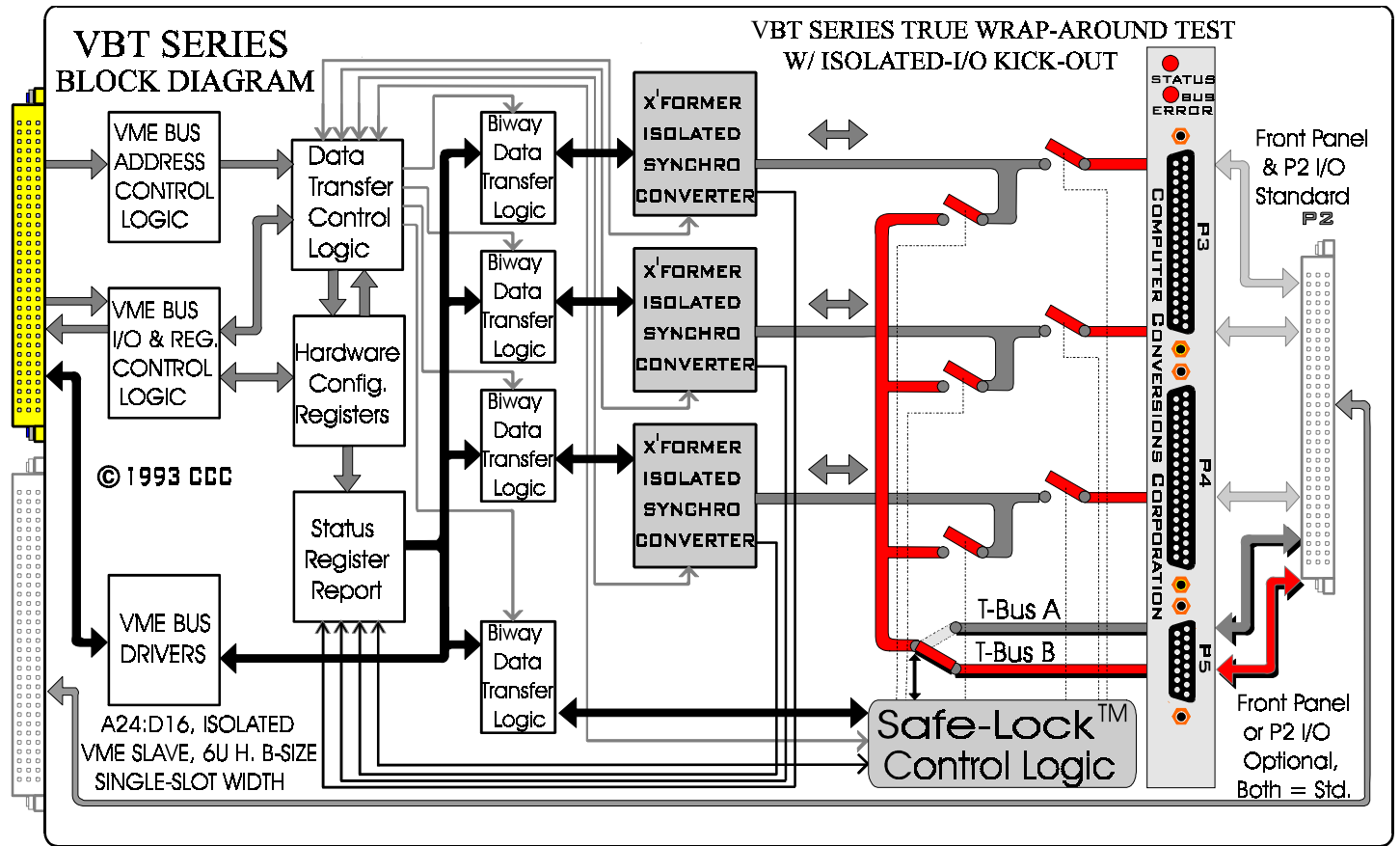
Application Testing

Loop-back testing is primarily used immediately following power-ups, to step the converters through a user programmed exercise.

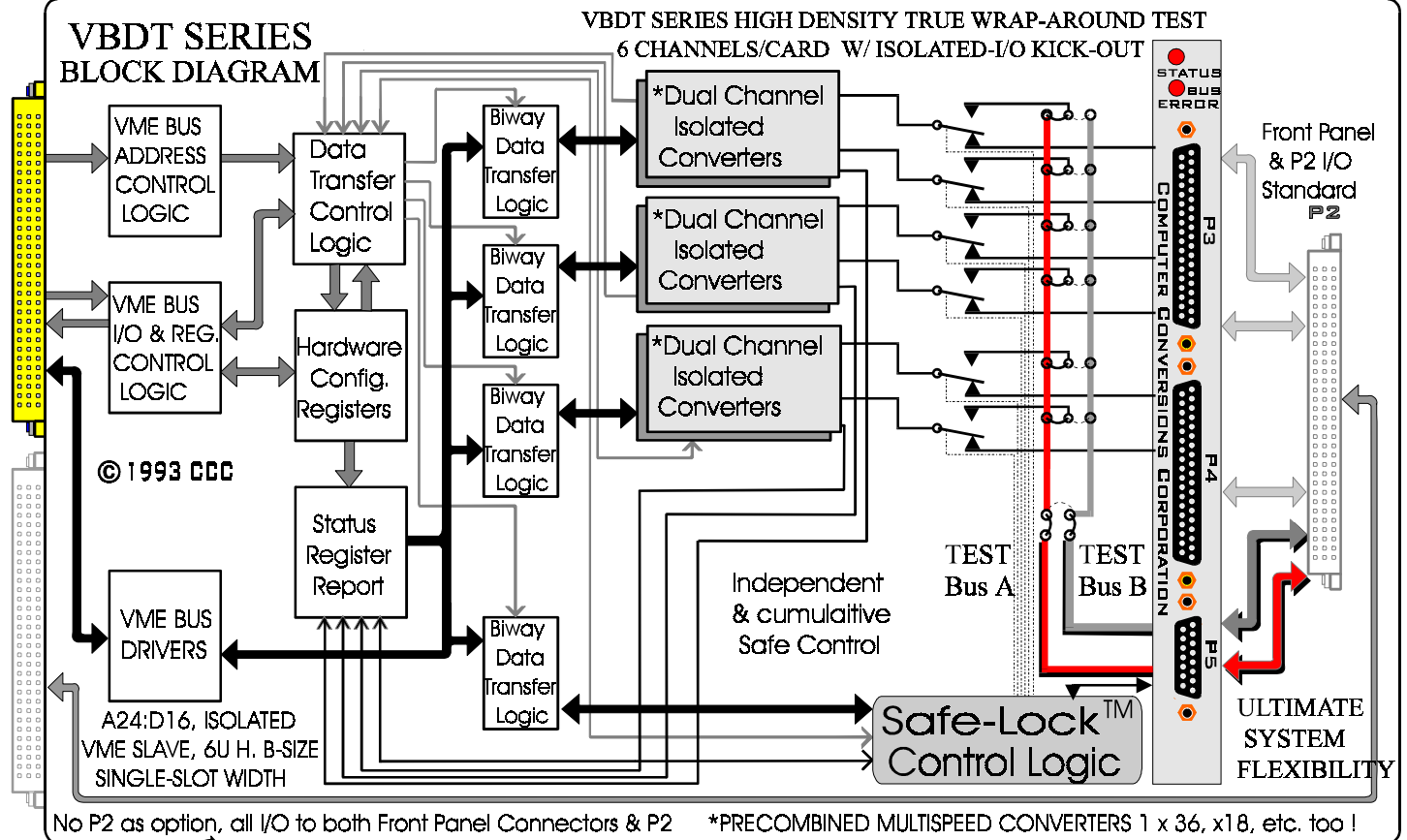
Real-time testing is performed by monitoring the signals and converters while in operation, and/or comparing the actual performance with another channel in the system (running concurrent to the live channel being tested), or a simulation of the expected.

The use of 100% transformer-isolated converters and a physically isolated test bus switching matrix; allows users to integrate Automatic Test Systems with guaranteed confidence and 100% assured performance.

VBT and VBDT Block Diagrams, Extensive True Wrap-Around Self-Test , Request VBT/VBDT Data Sheets



NOTE: FOR INPUT CONVERTERS; COMPLIMENTRY OUTPUT CONVERTERS OR FIXED ANGLE TEST PLUGS CAN ALSO BE USED.



No P2 as option, all I/O to both Front Panel Connectors & P2 *PRECOMBINED MULTISPEED CONVERTERS 1 x 36, x18, etc. too !